## Search Notes



Application/Control	No
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10565688

Applicant(s)/Patent Under Reexamination

MIYANO ET AL.

Examiner

Bui-Pho, Pascal M

Art Unit

2878

## **SEARCHED**

Class	Subclass	Date	Examiner
250	234, 227.11, 227.2, 227.24, 227.26, 559.06, 559.29	10/25/07	pmb
359	664	10/25/07	pmb
73	105	10/25/07	pmb

## **SEARCH NOTES**

Search Notes	Date	Examiner
Classes 250, 73, 385, 359 - East Search (USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB)	10/25/07	pmb
Consulted with Patrick Lee (Class 250)	10/25/07	pmb

## **INTERFERENCE SEARCH**

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Class	Subclass	Date	Examiner

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